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# **Knowledge Engineering and Data Mining**

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Deadline for manuscript submissions:

closed (30 November 2022)

# **Message from the Guest Editors**

Dear Colleagues,

The Special Issue covers the entire knowledge engineering pipeline: From data acquisition and data mining to knowledge extraction and exploitation. The topics of interest include but are not limited to the following:

- knowledge engineering
- knowledge representation and reasoning
- decision support systems
- outliers mining
- data mining
- multidimensional data analysis
- supervised and unsupervised learning methods
- ontology
- knowledge-based systems
- ontology learning
- methods of knowledge base management, etc.

Welcome to contribute.











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## **Editor-in-Chief**

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## **Message from the Editor-in-Chief**

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